



30V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)}	I _D T _A = +25°C
30V	460m Ω @ V _{GS} = 4.5V	1.2A
	560mΩ @ V _{GS} = 2.5V	1.0A

Description

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Load Switch
- Portable Applications
- Power Management Functions

X2-DFN1006-3





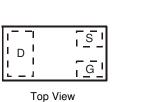
Bottom View

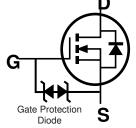
Features and Benefits

- 0.4mm Ultra Low Profile Package for Thin Application
- 0.6mm² Package Footprint, 10 times Smaller than SOT23
- Low V_{GS(TH).} Can Be Driven Directly From A Battery
- Low R_{DS(ON)}
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

- Case: X2-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound;
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe; Solderable per MIL-STD-202, Method 208
- Weight: 0.001 grams (Approximate)





Equivalent Circuit

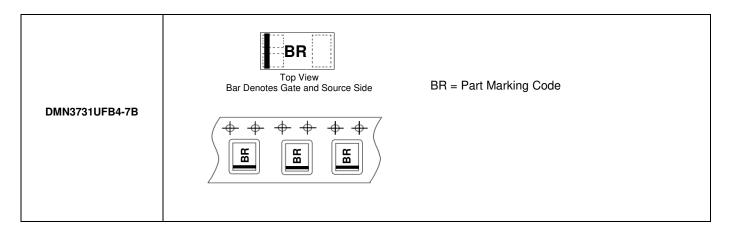
Ordering Information (Note 4)

Part Number	Marking	Reel Size (inches)	Tape Width (mm)	Tape Pitch (mm)	Quantity Per Reel
DMN3731UFB4-7B	BR	7	8	2	10,000

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information





Characteristic			Symbol	Value	Unit	
Drain-Source Voltage			V _{DSS}	30	V	
Gate-Source Voltage			V _{GSS}	±8		
Continuous Drain Current (Note 6) V _{GS} = 4.5V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	1.2 0.9	А	
Maximum Continuous Body Diode Forward Current (Note 6)			Is	1.2	А	
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)			I _{DM}	3	Α	

Thermal Characteristics (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)		P_{D}	0.52	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{ heta JA}$	240	°C/W
Total Power Dissipation (Note 6)		P _D	0.97	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	129	°C/W
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

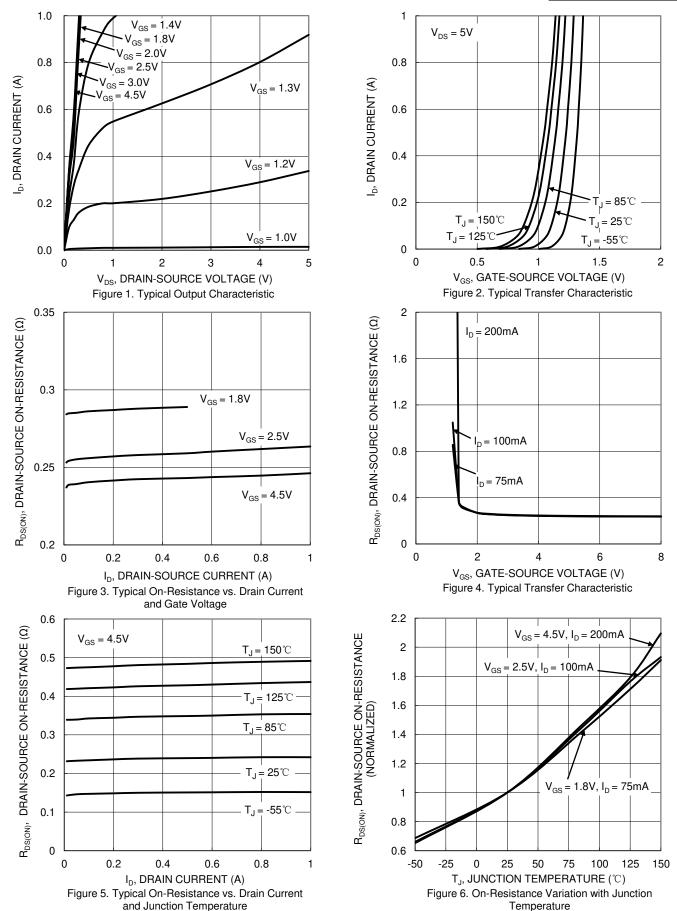
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)					•	
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_{D} = 10\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μΑ	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	3	μΑ	$V_{GS} = \pm 8V$, $V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						•
Gate Threshold Voltage	V _{GS(TH)}	0.45	_	0.95	٧	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
		_	297	460		$V_{GS} = 4.5V, I_D = 200mA$
Static Drain-Source On-Resistance	R _{DS(ON)}	_	311	560	mΩ	$V_{GS} = 2.5V, I_D = 100mA$
		_	335	730		V _{GS} = 1.8V, I _D = 75mA
Diode Forward Voltage	V _{SD}	_	1.0	1.2	V	V _{GS} = 0V, I _S = 300mA
DYNAMIC CHARACTERISTICS (Note 8)						•
Input Capacitance	C _{iss}	_	73	_	pF	
Output Capacitance	Coss	_	7.2	_	pF	$V_{DS} = 25V, V_{GS} = 0V,$ - f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	5	_	pF	-1 = 1.0Wil iz
Gate Resistance	Rg	_	902	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge	Qg	_	5.5	_	nC	
Gate-Source Charge	Q _{gs}	_	0.8	_	nC	$V_{GS} = 4.5V, V_{DS} = 15V,$
Gate-Drain Charge	Q_{gd}	_	1.4	_	nC	$-I_D = 1A$
Turn-On Delay Time	t _{D(ON)}	_	2.5	_	ns	
Turn-On Rise Time	t _R	_	3.1	_	ns	$V_{DS} = 10V, I_{D} = 1A$
Turn-Off Delay Time	t _{D(OFF)}	_	477	_	ns	$V_{GS} = 10V, R_G = 6\Omega$
Turn-Off Fall Time	t _F	_	123	_	ns	<u> </u>
Reverse Recovery Time	t _{RR}	_	59	_	ns	$I_F = 1A$, $di/dt = 100A/\mu s$
Reverse Recovery Charge	Q _{RR}	_	25	_	nC	I _F = 1A, di/dt = 100A/µs

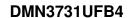
Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to production testing.











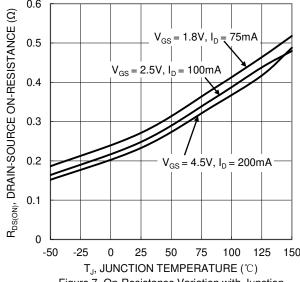


Figure 7. On-Resistance Variation with Junction Temperature

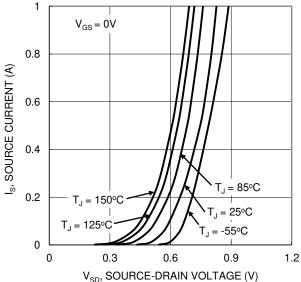
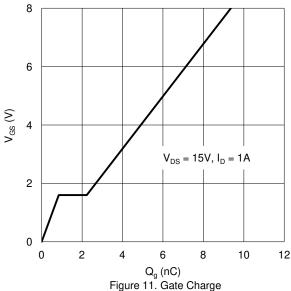


Figure 9. Diode Forward Voltage vs. Current



1.5 $V_{\text{GS(TH)}},$ GATE THRESHOLD VOLTAGE (V) 1.2 0.9 $I_D = 1mA$ 0.6 $I_{D} = 250 \mu A$ 0.3 0 -50 -25 25 50 75 100 125 150 T_J, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. Junction Temperature

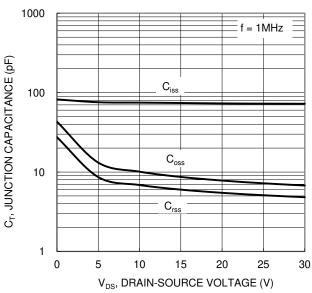


Figure 10. Typical Junction Capacitance

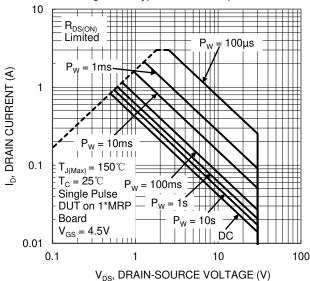


Figure 12. SOA, Safe Operation Area



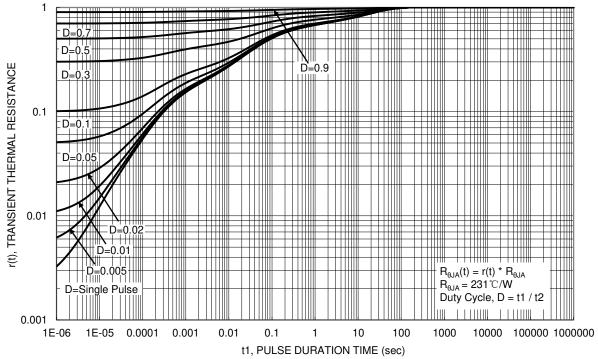


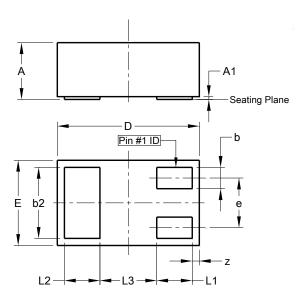
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-DFN1006-3

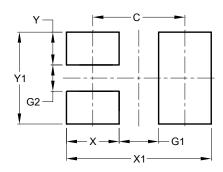


X2-DFN1006-3					
Dim	Min	Max	Тур		
Α		0.40			
A 1	0.00	0.05	0.03		
b	0.10	0.20	0.15		
b2	0.45	0.55	0.50		
D	0.95	1.05	1.00		
Е	0.55	0.65	0.60		
е	-	-	0.35		
L1	0.20	0.30	0.25		
L2	0.20	0.30	0.25		
L3	ı	ı	0.40		
Z	0.02	0.08	0.05		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-DFN1006-3



Dimensions	Value (in mm)
С	0.70
G1	0.30
G2	0.20
Х	0.40
X1	1.10
Y	0.25
Y1	0.70



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